

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/027,610	<b>Applicant(s)/Patent under Reexamination</b> WANG, CHENGHUI
	<b>Examiner</b> Steven HD Nguyen	<b>Art Unit</b> 2616

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner